

1-Mbit (128 K × 8) Static RAM

Features

- Pin- and function-compatible with CY7C1019B
- High speed

 □ t_{AA} = 10 ns
- Low active power
 □ I_{CC} = 80 mA @ 10 ns
- Low CMOS standby power
 □ I_{SB2} = 3 mA
- 2.0 V Data retention
- Automatic power-down when deselected
- CMOS for optimum speed/power
- Center power/ground pinout
- Easy memory expansion with $\overline{\text{CE}}$ and $\overline{\text{OE}}$ options
- Functionally equivalent to CY7C1019B
- Available in Pb-free 32-pin 400-Mil wide Molded SOJ and 32-pin TSOP II packages

Functional Description

The CY7C1019D $^{[1]}$ is a high-performance CMOS static RAM organized as 131,072 words by 8 bits. Easy memory expansion is provided by an active LOW Chip Enable ($\overline{\text{CE}}$), an active LOW Output Enable ($\overline{\text{OE}}$), and tri-state drivers. This device has an automatic power-down feature that significantly reduces power consumption when deselected. The eight input and output pins ($\overline{\text{IO}}_0$ through $\overline{\text{IO}}_7$) are placed in a high-impedance state when:

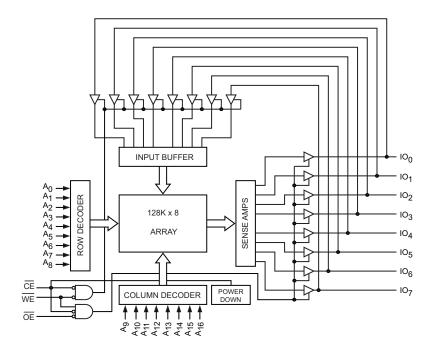
- Deselected (CE HIGH)
- Outputs are disabled (OE HIGH)
- When the write operation is active (CE LOW, and WE LOW).

Write to the device by taking Chip Enable (\overline{CE}) and Write Enable (\overline{WE}) inputs LOW. Data on the eight IO pins $(IO_0$ through $IO_7)$ is then written into the location specified on the address pins $(A_0$ through $A_{16})$.

Read from the device by taking Chip Enable (\overline{CE}) and Output Enable (\overline{OE}) LOW while forcing Write Enable (\overline{WE}) HIGH. Under these conditions, the contents of the memory location specified by the address pins appears on the IO pins.

The CY7C1019D device is suitable for interfacing with processors that have TTL I/P levels. It is not suitable for processors that require CMOS I/P levels. Please see Electrical Characteristics on page 4 for more details and suggested alternatives.

Logic Block Diagram



Note

1. For guidelines on SRAM system design, please refer to the 'System Design Guidelines' Cypress application note, available on the internet at www.cypress.com.





Contents

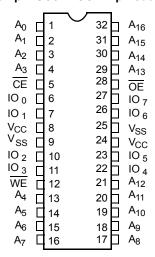
| Pin Configuration | 3 |
|--------------------------------|---|
| Selection Guide | |
| Maximum Ratings | 4 |
| Operating Range | 4 |
| Electrical Characteristics | 4 |
| Capacitance | 5 |
| Thermal Resistance | 5 |
| AC Test Loads and Waveforms | 5 |
| Data Retention Characteristics | 6 |
| Data Retention Waveform | |
| Switching Characteristics | |
| Switching Waveforms | |
| Truth Table | |

| Ordering Information | 11 |
|---|----|
| Ordering Code Definitions | |
| Package Diagrams | |
| Acronyms | |
| Document Conventions | |
| Units of Measure | 14 |
| Document History Page | 15 |
| Sales, Solutions, and Legal Information | 16 |
| Worldwide Sales and Design Support | |
| Products | |
| PSoC® Solutions | 16 |
| Cypress Developer Community | 16 |
| Technical Support | |



Pin Configuration

Figure 1. 32-pin SOJ / TSOP II pinout (Top View)



Selection Guide

| Description | -10 (Industrial) | Unit |
|---------------------------|------------------|------|
| Maximum Access Time | 10 | ns |
| Maximum Operating Current | 80 | mA |
| Maximum Standby Current | 3 | mA |



Maximum Ratings

Exceeding the maximum ratings may impair the useful life of the device. These user guidelines are not tested. Storage Temperature-65 °C to +150 °C

Ambient Temperature with

Supply Voltage on V $_{CC}$ to Relative GND $^{[2]}.....$ –0.5 V to +6.0 V

DC Voltage Applied to Outputs in High Z State $^{[2]}$-0.5 V to V $_{\rm CC}$ + 0.5 V

| DC Input Voltage [2] | 0.5 V to V _{CC} + 0.5 V |
|---|----------------------------------|
| Current into Outputs (LOW) | 20 mA |
| Static Discharge Voltage (per MIL-STD-883, Method 3015) | > 2001 V |
| Latch-up Current | > 200 mA |

Operating Range

| Range | Ambient Temperature | V _{CC} | Speed |
|------------|------------------------|-----------------|-------|
| Industrial | –40 °C to +85 °C | 5 V ± 0.5 V | 10 ns |

Electrical Characteristics

Over the Operating Range

| Doromotor | Description | Test Conditions | | -10 (Inc | dustrial) | Unit |
|------------------|--|---|---------|------------|-----------------------|-------|
| Parameter | Description | rest Conditions | | Min | Max | Oilit |
| V _{OH} | Output HIGH Voltage | I _{OH} = -4.0 mA | | 2.4 | - | V |
| | | I _{OH} = -0.1 mA | | - | 3.4 ^[3] | |
| V _{OL} | Output LOW Voltage | I _{OL} = 8.0 mA | | _ | 0.4 | V |
| V _{IH} | Input HIGH Voltage | | | 2.2 | V _{CC} + 0.5 | V |
| V _{IL} | Input LOW Voltage [2] | | | -0.5 | 0.8 | V |
| I _{IX} | Input Leakage Current | $GND \le V_1 \le V_{CC}$ | | –1 | +1 | μΑ |
| I _{OZ} | Output Leakage Current | $GND \le V_1 \le V_{CC}$, Output Disabled | | – 1 | +1 | μΑ |
| I _{CC} | V _{CC} Operating Supply Current | V _{CC} = Max, I _{OUT} = 0 mA, | 100 MHz | - | 80 | mA |
| | | $f = f_{max} = 1/t_{RC}$ | 83 MHz | _ | 72 | mA |
| | | | 66 MHz | _ | 58 | mA |
| | | | 40 MHz | - | 37 | mA |
| I _{SB1} | Automatic CE Power-Down Current – TTL Inputs | Max V_{CC} , $\overline{CE} \ge V_{IH}$, $V_{IN} \ge V_{IH}$ or $V_{IN} \le V_{IL}$, $f = f_{max}$ | | _ | 10 | mA |
| I _{SB2} | Automatic CE Power-Down Current – CMOS Inputs | $\begin{aligned} &\text{Max V}_{\text{CC}}, \overline{\text{CE}} \geq \text{V}_{\text{CC}} - 0.3 \text{ V}, \\ &\text{V}_{\text{IN}} \geq \text{V}_{\text{CC}} - 0.3 \text{ V}, \text{ or V}_{\text{IN}} \leq 0.3 \text{ V}, \text{ f} = \end{aligned}$ | 0 | _ | 3 | mA |

Note

Document Number: 38-05464 Rev. *H

V_{IL} (min) = -2.0 V and V_{IH}(max) = V_{CC} + 1 V for pulse durations of less than 5 ns.
 Please note that the maximum V_{OH} limit doesnot exceed minimum CMOS VIH of 3.5V. If you are interfacing this SRAM with 5 V legacy processors that require a minimum V_{IH} of 3.5 V, please refer to Application Note AN6081 for technical details and options you may consider.

Page 5 of 16



Capacitance

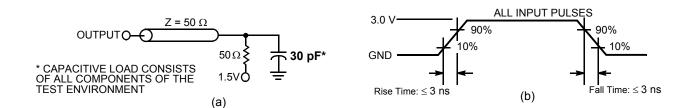
| Parameter [4] | Description | Test Conditions | Max | Unit |
|------------------|--------------------|--|-----|------|
| C _{IN} | Input capacitance | $T_A = 25 ^{\circ}\text{C}, f = 1 \text{MHz}, V_{CC} = 5.0 \text{V}$ | 6 | pF |
| C _{OUT} | Output capacitance | | 8 | pF |

Thermal Resistance

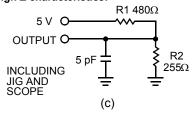
| Parameter [4] | Description | Test Conditions | 400-Mil Wide SOJ | TSOP II | Unit |
|-------------------|---------------------------------------|---|---------------------|---------|------|
| J/A | | Still Air, soldered on a 3 × 4.5 inch, four-layer printed circuit board | 56.29 | 62.22 | °C/W |
| $\Theta_{\sf JC}$ | Thermal resistance (junction to case) | | 38.14 | 21.43 | °C/W |

AC Test Loads and Waveforms

Figure 2. AC Test Loads and Waveforms [5]



High Z characteristics:



Notes

- 4. Tested initially and after any design or process changes that may affect these parameters.
 5. AC characteristics (except High Z) are tested using the load conditions shown in Figure 2 (a). High Z characteristics are tested for all speeds using the test load shown in Figure 2 (c).

Document Number: 38-05464 Rev. *H



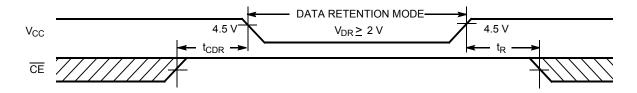
Data Retention Characteristics

Over the Operating Range

| Parameter | Parameter Description Conditions | | Min | Max | Unit |
|---------------------------------|--------------------------------------|--|-----------------|-----|------|
| V_{DR} | V _{CC} for Data Retention | | 2.0 | - | V |
| I _{CCDR} | Data Retention Current | $V_{CC} = V_{DR} = 2.0 \text{ V}, \overline{CE} \ge V_{CC} - 0.3 \text{ V},$ $V_{IN} \ge V_{CC} - 0.3 \text{ V or } V_{IN} \le 0.3 \text{ V}$ | _ | 3 | mA |
| t _{CDR} ^[6] | Chip Deselect to Data Retention Time | | 0 | _ | ns |
| t _R ^[7] | Operation Recovery Time | | t _{RC} | _ | ns |

Data Retention Waveform

Figure 3. Data Retention Waveform



Notes
6. Tested initially and after any design or process changes that may affect these parameters.
7. Full device operation requires linear V_{CC} ramp from V_{DR} to $V_{CC(min)} \ge 50 \, \mu s$ or stable at $V_{CC(min)} \ge 50 \, \mu s$.



Switching Characteristics

Over the Operating Range

| Parameter [8] | Description | -10 (Inc | dustrial) | 11!4 |
|-----------------------------------|---|----------|-----------|------|
| Parameter [9] | Description | Min | Max | Unit |
| Read Cycle | | <u> </u> | • | |
| t _{power} ^[9] | V _{CC} (typical) to the first access | 100 | _ | μS |
| t _{RC} | Read Cycle Time | 10 | _ | ns |
| t _{AA} | Address to Data Valid | - | 10 | ns |
| t _{OHA} | Data Hold from Address Change | 3 | - | ns |
| t _{ACE} | CE LOW to Data Valid | - | 10 | ns |
| t _{DOE} | OE LOW to Data Valid | - | 5 | ns |
| t _{LZOE} | OE LOW to Low Z | 0 | - | ns |
| t _{HZOE} | OE HIGH to High Z [10, 11] | - | 5 | ns |
| t _{LZCE} | CE LOW to Low Z [11] | 3 | _ | ns |
| t _{HZCE} | CE HIGH to High Z [10, 11] | - | 5 | ns |
| t _{PU} ^[12] | CE LOW to Power-Up | 0 | _ | ns |
| t _{PD} ^[12] | CE HIGH to Power-Down | - | 10 | ns |
| Write Cycle [13 | , 14] | | | |
| t _{WC} | Write Cycle Time | 10 | _ | ns |
| t _{SCE} | CE LOW to Write End | 7 | _ | ns |
| t _{AW} | Address Set-Up to Write End | 7 | _ | ns |
| t _{HA} | Address Hold from Write End | 0 | _ | ns |
| t _{SA} | Address Set-Up to Write Start | 0 | _ | ns |
| t _{PWE} | WE Pulse Width | | - | ns |
| t _{SD} | Data Set-Up to Write End | 6 | _ | ns |
| t _{HD} | Data Hold from Write End | 0 | - | ns |
| t _{LZWE} | WE HIGH to Low Z [11] | 3 | _ | ns |
| t _{HZWE} | WE LOW to High Z [10, 11] | _ | 5 | ns |

Notes

^{8.} Test conditions assume signal transition time of 3 ns or less, timing reference levels of 1.5 V, input pulse levels of 0 to 3.0 V, and output loading of the specified $I_{OL}I_{OH}$ and 30-pF load capacitance.

9. t_{POWER} gives the minimum amount of time that the power supply should be at typical V_{CC} values until the first memory access can be performed.

10. t_{HZOE} , t_{HZOE} , and t_{HZWE} are specified with a load capacitance of 5 pF as in (c) of Figure 2 on page 5. Transition is measured when the outputs enter a high impedance state.

11. At any given temperature and voltage condition, t_{HZCE} is less than t_{LZOE} , t_{HZOE} , and t_{HZWE} is less than t_{LZWE} for any given device.

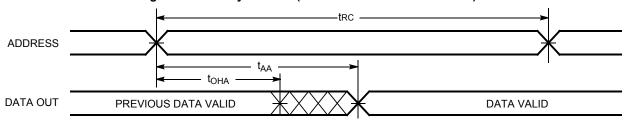
12. This parameter is guaranteed by design and is not tested.

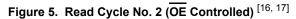
This parameter is guaranteed by design and is not tested.
 The internal write time of the memory is defined by the overlap of CE LOW and WE LOW. CE and WE must be LOW to initiate a write, and the transition of any of these signals can terminate the write. The input data <u>set</u>-up and hold <u>timing</u> should be referenced to the leading edge of the signal that terminates the write.
 The minimum write cycle time for Write Cycle no. 3 (WE controlled, OE LOW) is the sum of t_{HZWE} and t_{SD}.

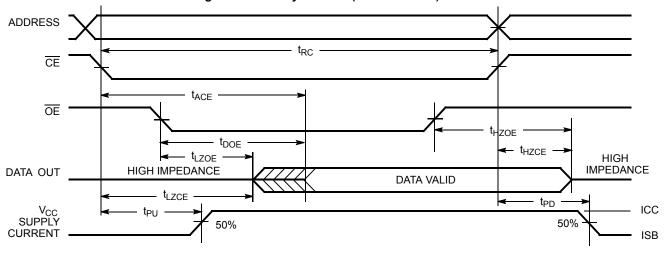


Switching Waveforms

Figure 4. Read Cycle No. 1 (Address Transition Controlled) [15, 16]







Notes

^{15. &}lt;u>Device</u> is continuously selected. <u>OE</u>, <u>CE</u> = V_{IL}.
16. <u>WE</u> is HIGH for Read cycle.

^{17.} Address valid prior to or coincident with $\overline{\text{CE}}$ transition LOW..



Switching Waveforms (continued)

Figure 6. Write Cycle No. 1 (CE Controlled) [18, 19]

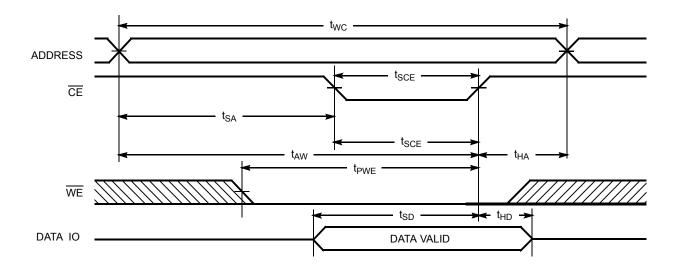
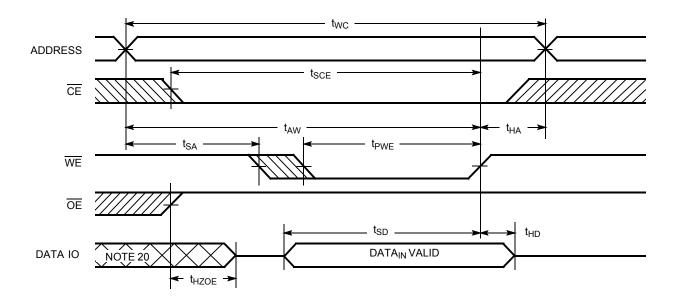


Figure 7. Write Cycle No. 2 (WE Controlled, OE HIGH During Write) [18, 19]

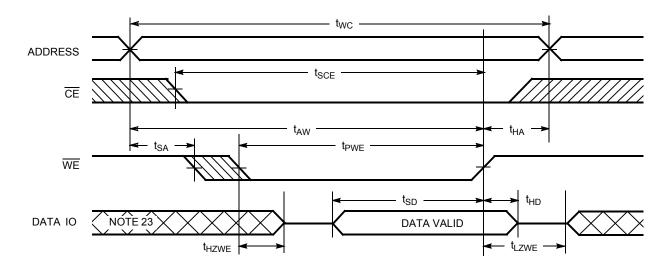


 ^{18.} Data IO is high impedance if OE = V_{IH}.
 19. If CE goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.
 20. During this period the IOs are in the output state and input signals should not be applied.



Switching Waveforms (continued)

Figure 8. Write Cycle No. 3 (WE Controlled, OE LOW) [21, 22]



Notes
21. The minimum write cycle time for Write Cycle no. 3 ($\overline{\text{WE}}$ controlled, $\overline{\text{OE}}$ LOW) is the sum of t_{HZWE} and t_{SD} .
22. If $\overline{\text{CE}}$ goes HIGH simultaneously with WE going HIGH, the output remains in a high-impedance state.
23. During this period the IOs are in the output state and input signals should not be applied.



Truth Table

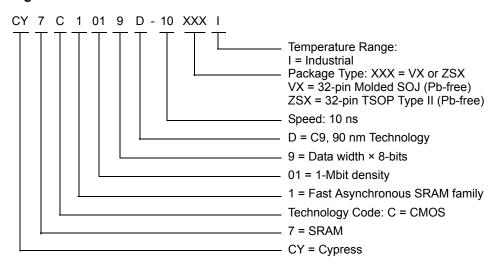
| CE | OE | WE | 10 ₀ –10 ₇ | Mode | Power |
|----|----|----|----------------------------------|----------------------------|----------------------------|
| Н | Х | Х | High Z | Power-Down | Standby (I _{SB}) |
| L | L | Н | Data Out | Read | Active (I _{CC}) |
| L | Х | L | Data In | Write | Active (I _{CC}) |
| L | Н | Н | High Z | Selected, Outputs Disabled | Active (I _{CC}) |

Ordering Information

| Speed (ns) | Ordering Code | Package Diagram | Package Type | Operating Range |
|------------|------------------|--------------------|---------------------------------------|--------------------|
| 10 | CY7C1019D-10VXI | 51-85033 | 32-pin (400-Mil) Molded SOJ (Pb-free) | Industrial |
| | CY7C1019D-10ZSXI | 51-85095 | 32-pin TSOP Type II (Pb-free) | |

Please contact your local Cypress sales representative for availability of these parts.

Ordering Code Definitions

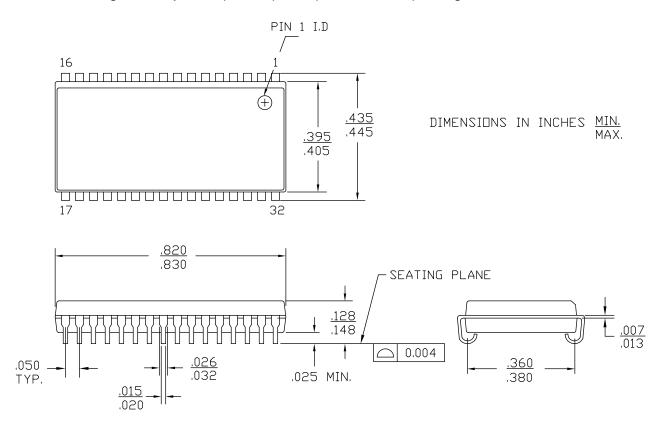


Document Number: 38-05464 Rev. *H



Package Diagrams

Figure 9. 32-pin SOJ (400 Mils) V32.4 (Molded SOJ V33) Package Outline, 51-85033

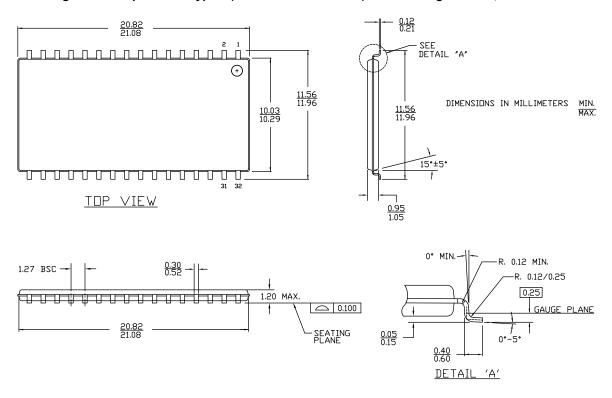


51-85033 *D



Package Diagrams (continued)

Figure 10. 32-pin TSOP Type II (20.95 × 11.76 × 1.0 mm) ZS32 Package Outline, 51-85095



51-85095 *B



Acronyms

| Acronym | Description | | |
|---------|---|--|--|
| CE | Chip Enable | | |
| CMOS | Complementary Metal Oxide Semiconductor | | |
| I/O | Input/Output | | |
| OE | Output Enable | | |
| SOJ | Small Outline J-lead | | |
| SRAM | Static Random Access Memory | | |
| TSOP | Thin Small Outline Package | | |
| TTL | Transistor-Transistor Logic | | |
| WE | Write Enable | | |

Document Conventions

Units of Measure

| Symbol | Unit of Measure | | | |
|--------|-----------------|--|--|--|
| °C | degree Celsius | | | |
| MHz | megahertz | | | |
| μΑ | microampere | | | |
| μs | microsecond | | | |
| mA | milliampere | | | |
| ms | millisecond | | | |
| mm | millimeter | | | |
| ns | nanosecond | | | |
| Ω | ohm | | | |
| % | percent | | | |
| pF | picofarad | | | |
| V | volt | | | |
| W | watt | | | |



Document History Page

| Document Title: CY7C1019D, 1-Mbit (128 K × 8) Static RAM Document Number: 38-05464 | | | | | | |
|--|---------|------------|--------------------|--|--|--|
| Rev. | ECN No. | Issue Date | Orig. of Change | Description of Change | | |
| ** | 201560 | See ECN | SWI | Advance Information data sheet for C9 IPP | | |
| *A | 233715 | See ECN | RKF | DC parameters are modified as per EROS (Spec # 01-2165) Pb-free offering in the Ordering Information | | |
| *B | 262950 | See ECN | RKF | Added T _{power} Spec in Switching Characteristics table Added Data Retention Characteristics table and waveforms Shaded Ordering Information | | |
| *C | 307598 | See ECN | RKF | Reduced Speed bins to -10 and -12 ns | | |
| *D | 520647 | See ECN | VKN | Converted from Preliminary to Final Removed Commercial Operating range Removed 12 ns speed bin Added I _{CC} values for the frequencies 83MHz, 66MHz and 40MHz Updated Thermal Resistance table Updated Ordering Information Table Changed Overshoot spec from V _{CC} +2V to V _{CC} +1V in footnote #2 | | |
| *E | 802877 | See ECN | VKN | Changed I _{CC} spec from 60 mA to 80 mA for 100MHz, 55 mA to 72 mA for 83MHz, 45 mA to 58 mA for 66MHz, 30 mA to 37 mA for 40MHz | | |
| *F | 3110052 | 12/14/2010 | AJU | Added Ordering Code Definitions. Updated Package Diagrams. | | |
| *G | 3245896 | 05/02/2011 | PRAS | Updated Package Diagrams. Added Acronyms and Units of Measure. Updated in new template. | | |
| *H | 4038234 | 06/24/2013 | MEMJ | Updated Functional Description. Updated Electrical Characteristics: Added one more Test Condition " $I_{OH} = -0.1$ mA" for V_{OH} parameter and added maximum value corresponding to that Test Condition. Added Note 3 and referred the same note in maximum value for V_{OH} parameter corresponding to Test Condition " $I_{OH} = -0.1$ mA". | | |



Sales, Solutions, and Legal Information

Worldwide Sales and Design Support

Cypress maintains a worldwide network of offices, solution centers, manufacturer's representatives, and distributors. To find the office closest to you, visit us at cypress.com/sales.

Products

Automotive Clocks & Buffers Interface

Lighting & Power Control

Memory PSoC Touch Sensing USB Controllers Wireless/RF cypress.com/go/automotive cypress.com/go/clocks cypress.com/go/interface cypress.com/go/powerpsoc cypress.com/go/plc cypress.com/go/memory cypress.com/go/psoc cypress.com/go/touch cypress.com/go/USB cypress.com/go/wireless

PSoC® Solutions

psoc.cypress.com/solutions PSoC 1 | PSoC 3 | PSoC 4 | PSoC 5LP

Cypress Developer Community

Community | Forums | Blogs | Video | Training

Technical Support

cypress.com/go/support

© Cypress Semiconductor Corporation, 2004-2013. The information contained herein is subject to change without notice. Cypress Semiconductor Corporation assumes no responsibility for the use of any circuitry other than circuitry embodied in a Cypress product. Nor does it convey or imply any license under patent or other rights. Cypress products are not warranted nor intended to be used for medical, life support, life saving, critical control or safety applications, unless pursuant to an express written agreement with Cypress. Furthermore, Cypress does not authorize its products for use as critical components in life-support systems where a malfunction or failure may reasonably be expected to result in significant injury to the user. The inclusion of Cypress products in life-support systems application implies that the manufacturer assumes all risk of such use and in doing so indemnifies Cypress against all charges.

Any Source Code (software and/or firmware) is owned by Cypress Semiconductor Corporation (Cypress) and is protected by and subject to worldwide patent protection (United States and foreign), United States copyright laws and international treaty provisions. Cypress hereby grants to licensee a personal, non-exclusive, non-transferable license to copy, use, modify, create derivative works of, and compile the Cypress Source Code and derivative works for the sole purpose of creating custom software and or firmware in support of licensee product to be used only in conjunction with a Cypress integrated circuit as specified in the applicable agreement. Any reproduction, modification, translation, or representation of this Source Code except as specified above is prohibited without the express written permission of Cypress.

Disclaimer: CYPRESS MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARD TO THIS MATERIAL, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE. Cypress reserves the right to make changes without further notice to the materials described herein. Cypress does not assume any liability arising out of the application or use of any product or circuit described herein. Cypress does not authorize its products for use as critical components in life-support systems where a malfunction or failure may reasonably be expected to result in significant injury to the user. The inclusion of Cypress' product in a life-support systems application implies that the manufacturer assumes all risk of such use and in doing so indemnifies Cypress against all charges.

Use may be limited by and subject to the applicable Cypress software license agreement.

Document Number: 38-05464 Rev. *H Revised June 25, 2013 Page 16 of 16

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for SRAM category:

Click to view products by Cypress manufacturer:

Other Similar products are found below:

CY6116A-35DMB CY7C1049GN-10VXI CY7C128A-45DMB GS8161Z36DD-200I GS88237CB-200I RMLV0408EGSB-4S2#AA0

IDT70V5388S166BG IS64WV3216BLL-15CTLA3 IS66WVE4M16ECLL-70BLI PCF8570P K6F2008V2E-LF70000 K6T4008C1B-GB70

CY7C1353S-100AXC AS6C8016-55BIN AS7C164A-15PCN 515712X IDT71V67603S133BG IS62WV51216EBLL-45BLI

IS63WV1288DBLL-10HLI IS66WVE2M16ECLL-70BLI 70V639S10BCG IS66WVE4M16EALL-70BLI IS62WV6416DBLL-45BLI

IS61WV102416DBLL-10TLI CY7C1381KV33-100AXC CY7C1381KVE33-133AXI 8602501XA 5962-3829425MUA 5962-3829430MUA

5962-8855206YA 5962-8866201YA 5962-8866204TA 5962-8866206MA 5962-8866208UA 5962-8872502XA 5962-9062007MXA 5962
9161705MXA 70V3579S6BFI GS882Z18CD-150I M38510/28902BVA 8413202RA 5962-8866203YA 5962-8871203XA 5962
8971202ZA 5962-8872501LA 5962-8866208YA 5962-8866205YA 5962-8866205UA 5962-8866203YA 5962-8855202YA